DE CS98

July 1, 2003

Commissioner of Patents and Trademarks

Washington, D.C. 20231

ATTN: Group Art Unit 2815 J. R. Diaz

From: Stephen B. Ackerman, Reg. No. 37,761

20 McIntosh Drive

Poughkeepsie, N. Y. 12603

Serial No. 09/764,242 01/19/2001

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A FILL PATTERN IN KERF AREAS TO PREVENT LOCALIZED NON-UNIFORMITIES OF INSULATING LAYERS AT DIE CORNERS ON SEMICONDUCTOR SUBSTRATES

!\_\_ Group Art Unit: 2815

J. R. Diaz

RESPONSE TO PATENT OFFICE ACTION

Dear Sir or Madam:

The Commissioner is hereby authorized to charge payment of any additional fees involved with added Claims and the like to Deposit Account No. 19-0033.

In response to Office Action dated April 24, 2003, please consider the following remarks.

## CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the U. S. Postal Service as first class mail in an envelope addressed to: Commissioner of Patents and Trademarks, Washington, D.C. 20231, on July 24 2003.

Stephen B. Ackerman, Reg. No. 37,761

Signature

Date 7/24/03